## MC10E151, MC100E151

## 5 V ECL 6-Bit D Register

## Description

The MC10E/100E151 contains 6 D-type, edge-triggered, master-slave flip-flops with differential outputs. Data enters the master when both CLK1 and CLK2 are LOW, and is transferred to the slave when CLK1 or CLK2 (or both) go HIGH. The asynchronous Master Reset (MR) makes all Q outputs go LOW.

The 100 Series contains temperature compensation.

## Features

- 1100 MHz Min. Toggle Frequency
- Differential Outputs
- Asynchronous Master Reset
- Dual Clocks
- PECL Mode Operating Range:
- $\mathrm{V}_{\mathrm{CC}}=4.2 \mathrm{~V}$ to 5.7 V with $\mathrm{V}_{\mathrm{EE}}=0 \mathrm{~V}$
- NECL Mode Operating Range:
- $\mathrm{V}_{\mathrm{CC}}=0 \mathrm{~V}$ with $\mathrm{V}_{\mathrm{EE}}=-4.2 \mathrm{~V}$ to -5.7 V
- Internal Input $50 \mathrm{k} \Omega$ Pulldown Resistors
- ESD Protection:
- Human Body Model; > 2 kV
- Machine Model; > 200 V
- Meets or Exceeds JEDEC Standard EIA/JESD78 IC Latchup Test
- Moisture Sensitivity Level: 3 (Pb-Free)
- For Additional Information, see Application Note AND8003/D
- Flammability Rating: UL 94 V-0 @ 0.125 in,

Oxygen Index: 28 to 34

- Transistor Count $=304$ devices
- These Devices are $\mathrm{Pb}-$ Free, Halogen Free and are RoHS Compliant

ON Semiconductor ${ }^{\circledR}$
www.onsemi.com


PLCC-28
FN SUFFIX
CASE 776-02

## MARKING DIAGRAM*


xxx = 10 or 100
A = Assembly Location
WL = Wafer Lot
YY = Year
WW = Work Week
$\mathrm{G} \quad=\mathrm{Pb}$-Free Package
*For additional marking information, refer to Application Note AND8002/D.

ORDERING INFORMATION

| Device | Package | Shipping ${ }^{\dagger}$ |
| :--- | :---: | :---: |
| MC10E151FNG | PLCC-28 <br> (Pb-Free) | 37 Units/Tube |
| MC10E151FNR2G | PLCC-28 <br> (Pb-Free) | $500 /$ /ape \& Reel |
| MC100E151FNG | PLCC-28 <br> (Pb-Free) | 37 Units/Tube |

$\dagger$ For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

## MC10E151, MC100E151



* All $\mathrm{V}_{\mathrm{CC}}$ and $\mathrm{V}_{\mathrm{CCO}}$ pins are tied together on the die.

Warning: All $\mathrm{V}_{\mathrm{CC}}, \mathrm{V}_{\mathrm{CCO}}$, and $\mathrm{V}_{\mathrm{EE}}$ pins must be externally connected to Power Supply to guarantee proper operation.

Figure 1. Pinout: PLCC-28 (Top View)


Figure 2. Logic Diagram

Table 1. PIN DESCRIPTION

| PIN | FUNCTION |
| :--- | :--- |
| $D_{0}-D_{5}$ | ECL Data Inputs |
| CLK1, CLK2 | ECL Clock Inputs |
| MR | ECL Master Reset |
| $Q_{0}-Q_{5}, \bar{Q}_{0}-\bar{Q}_{5}$ | ECL Differential Outputs |
| $V_{C C}, V_{C C O}$ | Positive Supply |
| $V_{\text {EE }}$ | Negative Supply |
| NC | No Connect |

Table 2. FUNCTION TABLE

| MR |  | Qn |
| :---: | :---: | :---: |
| 1 | Reset | L |
| 0 | Operational | H |

Table 3. MAXIMUM RATINGS

| Symbol | Parameter | Condition 1 | Condition 2 | Rating | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: |
| $\mathrm{V}_{\mathrm{CC}}$ | PECL Mode Power Supply | $\mathrm{V}_{\mathrm{EE}}=0 \mathrm{~V}$ |  | 8 | V |
| $\mathrm{V}_{\mathrm{EE}}$ | NECL Mode Power Supply | $\mathrm{V}_{\text {CC }}=0 \mathrm{~V}$ |  | -8 | V |
| $\mathrm{V}_{1}$ | PECL Mode Input Voltage NECL Mode Input Voltage | $\begin{aligned} & \mathrm{V}_{\mathrm{EE}}=0 \mathrm{~V} \\ & \mathrm{~V}_{\mathrm{CC}}=0 \mathrm{~V} \end{aligned}$ | $\begin{aligned} & \mathrm{V}_{1} \leq \mathrm{V}_{\mathrm{CC}} \\ & \mathrm{~V}_{\mathrm{I}} \geq \mathrm{V}_{\mathrm{EE}} \end{aligned}$ | $\begin{gathered} \hline 6 \\ -6 \end{gathered}$ | V |
| $\mathrm{I}_{\text {out }}$ | Output Current | Continuous Surge |  | $\begin{gathered} 50 \\ 100 \end{gathered}$ | mA |
| $\mathrm{T}_{\text {A }}$ | Operating Temperature Range |  |  | 0 to +85 | ${ }^{\circ} \mathrm{C}$ |
| $\mathrm{T}_{\text {stg }}$ | Storage Temperature Range |  |  | -65 to +150 | ${ }^{\circ} \mathrm{C}$ |
| $\theta_{\text {JA }}$ | Thermal Resistance (Junction-to-Ambient) | $\begin{array}{\|l\|} \hline 0 \text { lfpm } \\ 500 \text { lfpm } \end{array}$ | PLCC-28 | $\begin{aligned} & 63.5 \\ & 43.5 \end{aligned}$ | ${ }^{\circ} \mathrm{C} / \mathrm{W}$ |
| $\theta_{\text {Jc }}$ | Thermal Resistance (Junction-to-Case) | Standard Board | PLCC-28 | 22 to 26 | ${ }^{\circ} \mathrm{C} / \mathrm{W}$ |
| $\mathrm{V}_{\mathrm{EE}}$ | PECL Operating Range NECL Operating Range |  |  | $\begin{gathered} 4.2 \text { to } 5.7 \\ -5.7 \text { to }-4.2 \end{gathered}$ | V |
| $\mathrm{T}_{\text {sol }}$ | Wave Solder (Pb-Free) |  |  | 265 | ${ }^{\circ} \mathrm{C}$ |

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

Table 4. 10E SERIES PECL DC CHARACTERISTICS $\left(\mathrm{V}_{\mathrm{CC}}=5.0 \mathrm{~V}, \mathrm{~V}_{\mathrm{EE}}=0.0 \mathrm{~V}\right.$ (Note 1))

| Symbol | Characteristic | $0^{\circ} \mathrm{C}$ |  |  | $25^{\circ} \mathrm{C}$ |  |  | $85^{\circ} \mathrm{C}$ |  |  | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  | Min | Typ | Max | Min | Typ | Max | Min | Typ | Max |  |
| $\mathrm{I}_{\text {EE }}$ | Power Supply Current |  |  |  |  |  |  |  |  |  | mA |
| $\mathrm{V}_{\mathrm{OH}}$ | Output HIGH Voltage (Note 2) | 3980 | 4070 | 4160 | 4020 | 4105 | 4190 | 4090 | 4185 | 4280 | mV |
| $\mathrm{V}_{\text {OL }}$ | Output LOW Voltage (Note 2) | 3050 | 3210 | 3370 | 3050 | 3210 | 3370 | 3050 | 3227 | 3405 | mV |
| $\mathrm{V}_{\mathrm{IH}}$ | Input HIGH Voltage | 3830 | 3995 | 4160 | 3870 | 4030 | 4190 | 3940 | 4110 | 4280 | mV |
| $\mathrm{V}_{\mathrm{IL}}$ | Input LOW Voltage | 3050 | 3285 | 3520 | 3050 | 3285 | 3520 | 3050 | 3302 | 3555 | mV |
| $\mathrm{IIH}^{\text {H }}$ | Input HIGH Current |  |  |  |  |  |  |  |  |  | $\mu \mathrm{A}$ |
| IIL | Input LOW Current | 0.5 | 0.3 |  | 0.5 | 0.25 |  | 0.3 | 0.2 |  | $\mu \mathrm{A}$ |

NOTE: Device will meet the specifications after thermal equilibrium has been established when mounted in a test socket or printed circuit board with maintained transverse airflow greater than 500 lfpm. Electrical parameters are guaranteed only over the declared operating temperature range. Functional operation of the device exceeding these conditions is not implied. Device specification limit values are applied individually under normal operating conditions and not valid simultaneously.

1. Input and output parameters vary $1: 1$ with $\mathrm{V}_{\mathrm{CC}}$. $\mathrm{V}_{\mathrm{EE}}$ can vary $-0.46 \mathrm{~V} /+0.06 \mathrm{~V}$.
2. Outputs are terminated through a $50 \Omega$ resistor to $\mathrm{V}_{\mathrm{CC}}-2.0 \mathrm{~V}$.

Table 5. 10E SERIES NECL DC CHARACTERISTICS $\left(\mathrm{V}_{C C x}=0.0 \mathrm{~V} ; \mathrm{V}_{\mathrm{EE}}=-5.0 \mathrm{~V}\right.$ (Note 1))

| Symbol | Characteristic | $0^{\circ} \mathrm{C}$ |  |  | $25^{\circ} \mathrm{C}$ |  |  | $85^{\circ} \mathrm{C}$ |  |  | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  | Min | Typ | Max | Min | Typ | Max | Min | Typ | Max |  |
| $I_{\text {EE }}$ | Power Supply Current |  |  |  |  |  |  |  |  |  | mA |
| $\mathrm{V}_{\mathrm{OH}}$ | Output HIGH Voltage (Note 2) | -1020 | -930 | -840 | -980 | -895 | -810 | -910 | -815 | -720 | mV |
| $\mathrm{V}_{\mathrm{OL}}$ | Output LOW Voltage (Note 2) | -1950 | -1790 | -1630 | -1950 | -1790 | -1630 | -1950 | -1773 | -1595 | mV |
| $\mathrm{V}_{\mathrm{IH}}$ | Input HIGH Voltage | -1170 | -1005 | -840 | -1130 | -970 | -810 | -1060 | -890 | -720 | mV |
| $\mathrm{V}_{\text {IL }}$ | Input LOW Voltage | -1950 | -1715 | -1480 | -1950 | -1715 | -1480 | -1950 | -1698 | -1445 | mV |
| $\mathrm{IIH}^{\text {I }}$ | Input HIGH Current |  |  |  |  |  |  |  |  |  | $\mu \mathrm{A}$ |
| IIL | Input LOW Current | 0.5 | 0.3 |  | 0.5 | 0.065 |  | 0.3 | 0.2 |  | $\mu \mathrm{A}$ |

NOTE: Device will meet the specifications after thermal equilibrium has been established when mounted in a test socket or printed circuit board with maintained transverse airflow greater than 500 lfpm. Electrical parameters are guaranteed only over the declared operating temperature range. Functional operation of the device exceeding these conditions is not implied. Device specification limit values are applied individually under normal operating conditions and not valid simultaneously.

1. Input and output parameters vary $1: 1$ with $\mathrm{V}_{\mathrm{CC}}$. $\mathrm{V}_{\text {EE }}$ can vary $-0.46 \mathrm{~V} /+0.06 \mathrm{~V}$.
2. Outputs are terminated through a $50 \Omega$ resistor to $\mathrm{V}_{\mathrm{CC}}-2.0 \mathrm{~V}$.

Table 6. 100E SERIES PECL DC CHARACTERISTICS $\left(\mathrm{V}_{\mathrm{CCx}}=5.0 \mathrm{~V} ; \mathrm{V}_{\mathrm{EE}}=0.0 \mathrm{~V}\right.$ (Note 1))

| Symbol | Characteristic | $0^{\circ} \mathrm{C}$ |  |  | $25^{\circ} \mathrm{C}$ |  |  | $85^{\circ} \mathrm{C}$ |  |  | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  | Min | Typ | Max | Min | Typ | Max | Min | Typ | Max |  |
| $I_{\text {EE }}$ | Power Supply Current |  | 65 | 78 |  | 65 | 78 |  | 75 | 90 | mA |
| $\mathrm{V}_{\mathrm{OH}}$ | Output HIGH Voltage (Note 2) | 3975 | 4050 | 4120 | 3975 | 4050 | 4120 | 3975 | 4050 | 4120 | mV |
| $\mathrm{V}_{\mathrm{OL}}$ | Output LOW Voltage (Note 2) | 3190 | 3295 | 3380 | 3190 | 3255 | 3380 | 3190 | 3260 | 3380 | mV |
| $\mathrm{V}_{\mathrm{IH}}$ | Input HIGH Voltage | 3835 | 3975 | 4120 | 3835 | 3975 | 4120 | 3835 | 3975 | 4120 | mV |
| $\mathrm{V}_{\mathrm{IL}}$ | Input LOW Voltage | 3190 | 3355 | 3525 | 3190 | 3355 | 3525 | 3190 | 3355 | 3525 | mV |
| $\mathrm{I}_{\mathrm{H}}$ | Input HIGH Current |  |  | 150 |  |  | 150 |  |  | 150 | $\mu \mathrm{A}$ |
| IIL | Input LOW Current | 0.5 | 0.3 |  | 0.5 | 0.25 |  | 0.5 | 0.2 |  | $\mu \mathrm{A}$ |

NOTE: Device will meet the specifications after thermal equilibrium has been established when mounted in a test socket or printed circuit board with maintained transverse airflow greater than 500 lfpm. Electrical parameters are guaranteed only over the declared operating temperature range. Functional operation of the device exceeding these conditions is not implied. Device specification limit values are applied individually under normal operating conditions and not valid simultaneously.

1. Input and output parameters vary $1: 1$ with $\mathrm{V}_{\mathrm{CC}}$. $\mathrm{V}_{\mathrm{EE}}$ can vary $-0.46 \mathrm{~V} /+0.8 \mathrm{~V}$.
2. Outputs are terminated through a $50 \Omega$ resistor to $\mathrm{V}_{\mathrm{CC}}-2$ volts.

Table 7. 100E SERIES NECL DC CHARACTERISTICS $\left(\mathrm{V}_{\mathrm{CCx}}=0.0 \mathrm{~V} ; \mathrm{V}_{E E}=-5.0 \mathrm{~V}\right.$ (Note 1))

| Symbol | Characteristic | $0^{\circ} \mathrm{C}$ |  |  | $25^{\circ} \mathrm{C}$ |  |  | $85^{\circ} \mathrm{C}$ |  |  | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  | Min | Typ | Max | Min | Typ | Max | Min | Typ | Max |  |
| $\mathrm{I}_{\text {EE }}$ | Power Supply Current |  | 65 | 78 |  | 65 | 78 |  | 75 | 90 | mA |
| $\mathrm{V}_{\mathrm{OH}}$ | Output HIGH Voltage (Note 2) | -1025 | -950 | -880 | -1025 | -950 | -880 | -1025 | -950 | -880 | mV |
| $\mathrm{V}_{\text {OL }}$ | Output LOW Voltage (Note 2) | -1810 | -1705 | -1620 | -1810 | -1745 | -1620 | -1810 | -1740 | -1620 | mV |
| $\mathrm{V}_{\mathrm{IH}}$ | Input HIGH Voltage | -1165 | -1025 | -880 | -1165 | -1025 | -880 | -1165 | -1025 | -880 | mV |
| $\mathrm{V}_{\text {IL }}$ | Input LOW Voltage | -1810 | -1645 | -1475 | -1810 | -1645 | -1475 | -1810 | -1645 | -1475 | mV |
| $\mathrm{IIH}^{\text {I }}$ | Input HIGH Current |  |  | 150 |  |  | 150 |  |  | 150 | $\mu \mathrm{A}$ |
| IIL | Input LOW Current | 0.5 | 0.3 |  | 0.5 | 0.25 |  | 0.5 | 0.2 |  | $\mu \mathrm{A}$ |

NOTE: Device will meet the specifications after thermal equilibrium has been established when mounted in a test socket or printed circuit board with maintained transverse airflow greater than 500 lfpm . Electrical parameters are guaranteed only over the declared operating temperature range. Functional operation of the device exceeding these conditions is not implied. Device specification limit values are applied individually under normal operating conditions and not valid simultaneously.

1. Input and output parameters vary $1: 1$ with $\mathrm{V}_{\mathrm{CC}}$. $\mathrm{V}_{\mathrm{EE}}$ can vary $-0.46 \mathrm{~V} /+0.8 \mathrm{~V}$.
2. Outputs are terminated through a $50 \Omega$ resistor to $\mathrm{V}_{\mathrm{CC}}-2.0 \mathrm{~V}$.

Table 8. AC CHARACTERISTICS $\left(\mathrm{V}_{\mathrm{CCx}}=5.0 \mathrm{~V} ; \mathrm{V}_{\mathrm{EE}}=0.0 \mathrm{~V}\right.$ or $\mathrm{V}_{\mathrm{CCx}}=0.0 \mathrm{~V} ; \mathrm{V}_{\mathrm{EE}}=-5.0 \mathrm{~V}$ (Note 1))

| Symbol | Characteristic | $0^{\circ} \mathrm{C}$ |  |  | $25^{\circ} \mathrm{C}$ |  |  | $85^{\circ} \mathrm{C}$ |  |  | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  | Min | Typ | Max | Min | Typ | Max | Min | Typ | Max |  |
| $\mathrm{f}_{\text {MAX }}$ | Maximum Toggle Frequency | 900 | 1100 |  | 900 | 1100 |  | 900 | 1100 |  | MHz |
| $\mathrm{T}_{\mathrm{PLH}}$ $\mathrm{t}_{\mathrm{PHL}}$ | Propagation Delay to Output CLK, MR | 575 | 650 | 900 | 575 | 650 | 900 | 575 | 650 | 900 | ps |
| $\mathrm{t}_{\mathrm{s}}$ | Setup Time D | 0 | -175 |  | 0 | -175 |  | 0 | -175 |  | ps |
| $t_{\text {h }}$ | $\begin{aligned} & \text { Hold Time } \\ & \mathrm{D} \end{aligned}$ | 350 | 175 |  | 350 | 175 |  | 350 | 175 |  | ps |
| $\mathrm{t}_{\text {RR }}$ | Reset Recovery Time | 750 | 550 |  | 750 | 550 |  | 750 | 550 |  |  |
| tpW | Minimum Pulse Width CLK, MR | 400 |  |  | 400 |  |  | 400 |  |  | ps |
| tskew | Within-Device Skew (Note 2) |  | 65 |  |  | 65 |  |  | 65 |  | ps |
| $\mathrm{t}_{\text {JITTER }}$ | Random Clock Jitter (RMS) |  | < 1 |  |  | < 1 |  |  | < 1 |  | ps |
| $\mathrm{tr}_{\mathrm{r}} \mathrm{t}_{\mathrm{f}}$ | $\begin{aligned} & \text { Rise/Fall Times } \\ & (20-80 \%) \end{aligned}$ | 300 | 450 | 700 | 300 | 450 | 700 | 300 | 450 | 700 | ps |

NOTE: Device will meet the specifications after thermal equilibrium has been established when mounted in a test socket or printed circuit board with maintained transverse airflow greater than 500 lfpm. Electrical parameters are guaranteed only over the declared operating temperature range. Functional operation of the device exceeding these conditions is not implied. Device specification limit values are applied individually under normal operating conditions and not valid simultaneously.

1. 10 Series: $\mathrm{V}_{\mathrm{EE}}$ can vary $-0.46 \mathrm{~V} /+0.06 \mathrm{~V}$.

100 Series: VEE can vary $-0.46 \mathrm{~V} /+0.8 \mathrm{~V}$.
2. Within-device skew is defined as identical transitions on similar paths through a device.


Figure 3. Typical Termination for Output Driver and Device Evaluation (See Application Note AND8020/D - Termination of ECL Logic Devices.)

Resource Reference of Application Notes
AN1405/D - ECL Clock Distribution Techniques
AN1406/D - Designing with PECL (ECL at +5.0 V)
AN1503/D - ECLinPS $^{\text {M }}$ I/O SPiCE Modeling Kit
AN1504/D - Metastability and the ECLinPS Family $^{\text {AN1568/D }}-$ Interfacing Between LVDS and ECL
AN1672/D - The ECL Translator Guide
AND8001/D - Odd Number Counters Design
AND8002/D - Marking and Date Codes
AND8020/D - Termination of ECL Logic Devices
AND8066/D - Interfacing with ECLinPS
AND8090/D - AC Characteristics of ECL Devices

## MC10E151, MC100E151

## PACKAGE DIMENSIONS

28 LEAD PLLC
CASE 776-02
ISSUE F


NOTES

1. DATUMS -L-, -M-, AND -N- DETERMINED WHERE TOP OF IEAD SHOULDER EXITS PLASTIC BODY AT MOLD PARTING LINE 2. DIMENSION G1, TRUE POSITION TO BE MEASURED AT DATUM -T-, SEATING PLANE . DIMENSIONS R AND U DO NOT INCLUDE MOLD FLASH. ALLOWABLE MOLD FLASH IS 0.010 (0.250) PER SIDE.

DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
CONTROLLING DIMENSION: INCH
6. THE PACKAGE TOP MAY BE SMALLER THAN THE PACKAGE BOTTOM BY UP TO 0.012 (0.300). DIMENSIONS R AND U ARE DETERMINED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY EXTREMES OF THE PLASTIC BODY EXCLUSIVE OF MOLD FLASH, TIE BAR
BURRS, GATE BURRS AND INTERLEAD BURRS, GATE BURRS AND INTERLEAD
FLASH, BUT INCLUDING ANY MISMATCH FLASH, BUT INCLUDING ANY MISMATCH
BETWEEN THE TOP AND BOTTOM OF THE PLASTIC BODY.
7. DIMENSION H DOES NOT INCLUDE DAMBAR PROTRUSION OR INTRUSION. THE DAMBAR PROTRUSION(S) SHALL NOT CAUSE THE H DIMENSION TO BE GREATER THAN 0.037 (0.940). THE DAMBAR INTRUSION(S) SHALL NOT CAUSE THE H DIMENSION TO BE SMALLER THAN 0.025 (0.635).

| DIM | INCHES |  | MILLIMETERS |  |
| :---: | :---: | :---: | :---: | :---: |
|  | MIN | MAX | MIN | MAX |
| A | 0.485 | 0.495 | 12.32 | 12.57 |
| B | 0.485 | 0.495 | 12.32 | 12.57 |
| C | 0.165 | 0.180 | 4.20 | 4.57 |
| E | 0.090 | 0.110 | 2.29 | 2.79 |
| F | 0.013 | 0.021 | 0.33 | 0.53 |
| G | 0.050 BSC |  | 1.27 | BSC |
| H | 0.026 | 0.032 | 0.66 | 0.81 |
| J | 0.020 | --- | 0.51 | --- |
| K | 0.025 | --- | 0.64 | --- |
| R | 0.450 | 0.456 | 11.43 | 11.58 |
| U | 0.450 | 0.456 | 11.43 | 11.58 |
| V | 0.042 | 0.048 | 1.07 | 1.21 |
| W | 0.042 | 0.048 | 1.07 | 1.21 |
| X | 0.042 | 0.056 | 1.07 | 1.42 |
| Y | --- | 0.020 | --- | 0.50 |
| Z | $2{ }^{\circ}$ | $10^{\circ}$ | $2{ }^{\circ}$ | $10^{\circ}$ |
| G1 | 0.410 | 0.430 | 10.42 | 10.92 |
| K1 | 0.040 | --- | 1.02 | --- |

## MC10E151, MC100E151

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